2410 and 2410-C SourceMeter® Specifications

SOURCE SPECIFICATIONS¹

VOLTAGE PROGRAMMING ACCURACY (LOCAL OR REMOTE SENSE)

RANGE	PROGRAMMING RESOLUTION	ACCURACY (1 Year) 23°C ±5°C ±(% rdg. + volts)	NOISE (peak-peak) 0.1Hz – 10Hz
200.00 mV	5 μV	$0.02\% + 600 \mu V$	5 μV
2.00000 V	50 μV	$0.02\% + 600 \mu V$	50 μV
20.0000 V	500 μV	0.02% + 2.4 mV	5 mV
1000.00 V	50 mV	0.02% + 100 mV	20 mV

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): ±(0.15 × accuracy specification)/ °C.

MAX. OUTPUT POWER: 22W, four quadrant source or sink operation.

SOURCE/SINK LIMITS: ±21V @ ±1.05A, ±1100V @ ±21mA.

VOLTAGE REGULATION: Line: 0.01% of range. Load: 0.01% of range + 1mV.

NOISE 10Hz - 1MHz (p-p): 20mV typical into a resistive load.

OVER VOLTAGE PROTECTION: User selectable values, 5% tolerance. Factory

default = none.

CURRENT LIMIT: Bipolar current limit (compliance) set with single value. Min. 0.1% of range.

OVERSHOOT: <0.1% typical (full scale step, resistive load, 20mA range).

CURRENT PROGRAMMING ACCURACY (LOCAL OR REMOTE SENSE)

RANGE	PROGRAMMING RESOLUTION	ACCURACY (1 Year) ³ 23°C ±5°C ±(% rdg. + amps)	NOISE (peak-peak) 0.1Hz – 10Hz
1.00000 μΑ	50 pA	0.035% + 600 pA	5 pA
10.0000 μΑ	500 pA	0.033% + 2 nA	50 pA
100.000 μΑ	5 nA	0.031% + 20 nA	500 pA
1.00000 mA	50 nA	0.034% + 200 nA	5 nA
20.0000 mA	500 nA	$0.045\% + 4 \mu A$	200 nA
100.000 mA	5 μΑ	$0.066\% + 20 \mu A$	1 μΑ
1.00000 A ²	50 μΑ	$0.27\% + 900 \mu A$	100 μΑ

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): ±(0.15 × accuracy specification)/ °C.

MAX. OUTPUT POWER: 22W, four quadrant source or sink operation.

SOURCE/SINK LIMITS: ±1.05A @ ±21V, ±21 mA @ ±1100V.

CURRENT REGULATION: Line: 0.01% of range. Load: 0.01% of range + 1nA.

VOLTAGE LIMIT: Bipolar voltage limit (compliance) set with single value. Min. 0.1% of range.

OVERSHOOT: <0.1% typical (1mA step, RL = $10k\Omega$, 20V range).

ADDITIONAL SOURCE SPECIFICATIONS

TRANSIENT RESPONSE TIME: 30µs minimum for the output to recover to its spec. following a step change in load.

COMMAND PROCESSING TIME: Maximum time required for the output to begin to change following the receipt of :SOURce:VOLTage|CURRent <nrf> command. Autorange On: 10ms. Autorange Off: 7ms.

OUTPUT SETTLING TIME: Time required to reach 0.1% of final value after command is processed. 100µs typical. Resistive load. 10µA to 100mA range.

OUTPUT SLEW RATE (±30%):

0.5V/μs, 1000V range, 20mA compliance. 0.15V/μs, 20V range, 100mA compliance.

DC FLOATING VOLTAGE: Output can be floated up to ±250VDC from chassis ground.

REMOTE SENSE: Up to 1V drop per load lead.

COMPLIANCE ACCURACY: Add 0.3% of range and ±0.02% of reading to base specification.

OVER TEMPERATURE PROTECTION: Internally sensed temperature overload puts unit in standby mode.

RANGE CHANGE OVERSHOOT: Overshoot into a fully resistive 100kΩ load, 10Hz to 1MHz BW, adjacent range changes between 200mV, 2V, and 20V ranges, 100mV typical

MINIMUM COMPLIANCE VALUE: 0.1% of range.

- Specifications valid for continuous output currents below 105mA.
 For operation above 105mA continuous for > 1 minute, derate accuracy 10%/35mA above 105mA.
- 2. Full operation (1A) regardless of load to 30°C. Above 30°C ambient, derate 35mA/°C and prorate 35mA/Ω load. 4-wire mode. For current sink operation on 1A range, maximum continuous power is limited to approximately 1/2 rated power or less, depending on current, up to 30°C ambient. See power equations in the User's Manual to calculate allowable duty cycle for specific conditions.
- calculate allowable duty cycle for specific conditions.

 For sink mode, JµA to 100mA range, accuracy is:

 ±(0.5% + offset*3)

 For 1A range, accuracy is:

 ±(1.5% + offset*3)

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MEASURE SPECIFICATIONS^{1,2}

VOLTAGE MEASUREMENT ACCURACY (LOCAL OR REMOTE SENSE)

RANGE	DEFAULT RESOLUTION	INPUT RESISTANCE	ACCURACY (1 Year) 23°C ±5°C ±(% rdg. + volts)
200.00 mV	1 μV	>10 GΩ	$0.012\% + 300 \; \mu V$
2.00000 V	10 μV	>10 GΩ	$0.012\% + 300 \; \mu V$
20.0000 V	100 μV	>10 GΩ	0.015% + 1 mV
1000.00 V	10 mV	>10 GΩ	0.015% + 50 mV

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): ±(0.15 × accuracy specification)/ °C.

CURRENT MEASUREMENT ACCURACY (LOCAL OR REMOTE SENSE)

RANGE	DEFAULT RESOLUTION	VOLTAGE BURDEN ³	ACCURACY (1 Year) 23°C ±5°C ±(% rdg. + amps)
1.00000 μΑ	10 pA	<1 mV	0.029% + 300 pA
10.0000 μΑ	100 pA	<1 mV	0.027% + 700 pA
100.000 μΑ	1 nA	<1 mV	0.025% + 6 nA
1.00000 mA	10 nA	<1 mV	0.027% + 60 nA
20.0000 mA	100 nA	<1 mV	$0.035\% + 1.2 \mu\text{A}$
100.000 mA	1 μΑ	<1 mV	$0.055\% + 6 \mu A$
1.00000 A	10 μΑ	<1 mV	$0.22\% + 570 \mu A$

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): ±(0.10 × accuracy specification)/ °C.

RESISTANCE MEASUREMENT ACCURACY (LOCAL OR REMOTE SENSE)

RANGE	DEFAULT RESOLUTION	DEFAULT TEST CURRENT	NORMAL ACCURACY (23°C ±5°C) 1 YEAR, ±(% rdg. + ohms)
$<2.00000 \Omega^4$	-	-	Source I_{ACC} + Meas. V_{ACC}
20.0000Ω	100 μΩ	100 mA	$0.11\% + 0.006 \Omega$
$200.000~\Omega$	1 mΩ	10 mA	$0.09\% + 0.12 \Omega$
$2.00000~\mathrm{k}\Omega$	10 mΩ	1 mA	$0.08\% + 0.6 \Omega$
$20.0000~\mathrm{k}\Omega$	100 mΩ	100 μΑ	$0.07\% + 6 \Omega$
200.000 kΩ	1 Ω	10 μΑ	$0.07\% + 60~\Omega$
$2.00000~\mathrm{M}\Omega$	10 Ω	1 μΑ	$0.12\% + 600 \Omega$
20.0000 MΩ	100 Ω	1 μΑ	$0.12\% + 2.4 \text{ k}\Omega$
$200.000~\mathrm{M}\Omega$	1 kΩ	100 nA	$0.66\% + 24 \text{ k}\Omega$
$> 200.000 \ \mathrm{M}\Omega^4$	-	-	Source I_{ACC} + Meas. V_{ACC}

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): ±(0.15 × accuracy specification)/ °C.

SOURCE I MODE, MANUAL OHMS: Total uncertainty = I source accuracy + V measure accuracy (4-wire remote sense).

SOURCE V MODE, MANUAL OHMS: Total uncertainty = V source accuracy + I measure accuracy (4-wire remote sense).

6-WIRE OHMS MODE: Available using active ohms guard and guard sense (except on 1A and 1000V ranges). Max. Guard Output Current: 40mA typical. Accuracy is load dependent. Refer to White Paper no. 2033 for calculation formula.

GUARD OUTPUT IMPEDANCE: $<0.1\Omega$ in ohms mode.

CONTACT CHECK SPECIFICATIONS

SPEED: 350us for verification and notification.

CONTACT CHECK:	2Ω	15Ω	50Ω
No contact check failure	<1.00Ω	<13.5Ω	<47.5Ω
Always contact check failure	>3.00Ω	>16.5Ω	>52.5Ω

- Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV and 1A ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, and 1A ranges, add 0.5%.
- 2. Accuracies apply to 2- or 4-wire mode when properly zeroed.
- 4-wire mode.
- Manual ohms only.

2410 and 2410-C SourceMeter® Specifications

SYSTEM SPEEDS

MEASUREMENT1

MAXIMUM RANGE CHANGE RATE: 70/second.

MAXIMUM MEASURE AUTORANGE TIME: 40ms (fixed source)².

SWEEP OPERATION³ READING RATES (rdg./second) FOR 60Hz (50Hz):

	NPLC/TRIGGER	MEA	MEASURE SOURCE-MEASURE ⁵		SOURCE-MEASURE PASS/FAIL TEST ^{4,5}		SOURCE-MEMORY ^{4,5}		
SPEED	ORIGIN	TO MEM.	TO GPIB	TO MEM	TO GPIB	TO MEM.	TO GPIB	TO MEM.	TO GPIB
Fast	0.01 / internal	2081 (2030)	1754	1551 (1515)	1369	902 (900)	981	165 (162)	165
IEEE-488.1 Mode	0.01 / external	1239 (1200)	1254	1018 (990)	1035	830 (830)	886	163 (160)	163
Fast	0.01 / internal	2801 (2030)	1198 (1210)	1551 (1515)	1000 (900)	902 (900)	809 (840)	165 (162)	164 (162)
IEEE-488.2 Mode	0.01 / external	1239 (1200)	1079 (1050)	1018 (990)	916 (835)	830 (830)	756 (780)	163 (160)	162 (160)
Medium	0.10 / internal	510 (433)	509 (433)	470 (405)	470 (410)	389 (343)	388 (343)	133 (126)	132 (126)
IEEE-488.2 Mode	0.10 / external	438 (380)	438 (380)	409 (360)	409 (365)	374 (333)	374 (333)	131 (125)	131 (125)
Normal	1.00 / internal	59 (49)	59 (49)	58 (48)	58 (48)	56 (47)	56 (47)	44 (38)	44 (38)
IEEE-488.2 Mode	1.00 / external	57 (48)	57 (48)	57 (48)	57 (47)	56 (47)	56 (47)	44 (38)	44 (38)

SINGLE READING OPERATION READINGRATES (rdg./second) FOR 60Hz (50Hz):

SPEED	NPLC/TRIGGER ORIGIN	MEASURE TO GPIB	SOURCE-MEASURE TO GPIB ⁵	SOURCE-MEASURE PASS/FAIL TEST ^{4,5} TO GPIB
Fast (488.1)	0.01 / internal	537	140	135
Fast (488.2)	0.01 / internal	256 (256)	79 (83)	79 (83)
Medium (488.2)	0.10 / internal	167 (166)	72 (70)	69 (70)
Normal (488.2)	1.00 / internal	49 (42)	34 (31)	35 (30)

COMPONENT INTERFACE HANDLER TIME FOR 60Hz (50Hz):4,6

SPEED	NPLC/TRIGGER ORIGIN	MEASURE TO GPIB	SOURCE PASS/FAIL TEST	SOURCE-MEASURE PASS/FAIL TEST ^{5,7} TO GPIB
Fast	0.01/ external	1.04 ms (1.08 ms)	0.5 ms (0.5 ms)	4.82 ms (5.3 ms)
Medium	0.10 / external	2.55 ms (2.9 ms)	0.5 ms (0.5 ms)	6.27 ms (7.1 ms)
Normal	1.00 / external	17.53 ms (20.9 ms)	0.5 ms (0.5 ms)	21.31 ms (25.0 ms)

RAL

- Reading rates applicable for voltage or current measurements. Auto zero off, autorange off, filter off, display off, trigger delay = 0, source auto-clear off, and binary reading format
- Purely resistive load. 1μA and 10μA ranges <65ms.
- 3. 1000 point sweep was characterized with the source on a fixed range.

- 4. Pass/Fail test performed using one high limit and one low math limit.
- 5. Includes time to re-program source to a new level before making measurement.
- 6. Time from falling edge of START OF TEST signal to falling edge of END OF TEST signal
- Command processing time of :SOURce:VOLTage|CURRent:TRIGgered <nrf> command not included.

	GENE
SE DE IECTION.	

NOISE REJECTION	ON:			
	NPLC	NMRR	CMRR	
Fast	0.01	-	80 dB	
Medium	0.1	-	80 dB	
Slow	1	60 dB	100 dB ¹	

Except lowest 2 current ranges – 90dB.

LOAD IMPEDANCE: Stable into 20,000pF typical. COMMON MODE VOLTAGE: 250V DC. COMMON MODE ISOLATION: >10°Q, <1000pF.

OVERRANGE: 105% of range, source and measure.

MAX. VOLTAGE DROP BETWEEN INPUT/OUTPUT AND SENSE

TERMINALS: 5V.

MAX. SENSE LEAD RESISTANCE: $50k\Omega$ for rated accuracy.

SENSE INPUT IMPEDANCE: $>10^{10}\Omega$

GUARD OFFSET VOLTAGE: <300µV, typical.

SOURCE OUTPUT MODES:

Fixed DC level

Memory List (mixed function)

Stair (linear and log)

SOURCE MEMORY LIST: 100 points max.

MEMORY BUFFER: 5,000 readings @ 5.5 digits (two 2,500 point buffers). Includes selected measured value(s) and time stamp. Lithium battery

backup (3 yr+ battery life).

PROGRAMMABILITY: IEEE-488 (SCPI-1996.0), RS-232, 5 user-definable power-up states plus factory default and *RST.

DIGITAL INTERFACE:

Output Enable: Active low input.

Handler Interface: Start of test, end of test, 3 category bits. +5V@

300mA supply.

Digital I/O: 1 trigger input, 4 TTL/Relay Drive outputs (33V @ 500mA, diode clamped).

POWER SUPPLY: 100V to 240V rms, 50–60Hz (automatically detected at power up). 210VA.

COOLING: Forced air, variable speed.

WARRANTY: 1 year.

EMC: Conforms to European Union Directive 89/336/EEC, EN 61326-1.

SAFETY: Conforms to European Union Directive 73/23/EEC, EN61010-1.

WARM-UP: 1 hour to rated accuracies.

DIMENSIONS: 89mm high \times 213mm wide \times 370mm deep (3 1/2 in \times 8 3/8 in \times 14 9/16 in). Bench Configuration (with handle & feet):104mm high \times 238mm wide \times 370mm deep (4 1/8 in \times 9 3/8 in \times 14 9/16 in).

WEIGHT: 3.3kg (7.3 lbs).

ENVIRONMENT:

For Indoor Use Only: Maximum 2000m above Sea Level

Operating: 0°–50°C, 70%R.H. up to 35°C. Derate 3% R.H./°C, 35°–50°C. **Storage:** –25°C to 65°C.

ACCESSORIES SUPPLIED: Test Leads, User's Manual, Service Manual, LabVIEW and TestPoint Drivers.

Specifications subject to change without notice.